

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/589,886 TAKEUCHI ET AL.	
		Examiner	Art Unit ALEXANDER BELOUSOV	2811 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0036678 A1	11-2001	Udagawa, Takashi	438/22
*	B	US-2002/0000563 A1	01-2002	Udagawa, Takashi	257/94
*	C	US-6,346,719 B1	02-2002	Udagawa et al.	257/94
*	D	US-6,512,248 B1	01-2003	Takeuchi et al.	257/81
*	E	US-2003/0001162 A1	01-2003	Udagawa, Takashi	257/79
*	F	US-2003/0027099 A1	02-2003	Udagawa, Takashi	433/79
*	G	US-6,531,716 B2	03-2003	Udagawa, Takashi	257/94
*	H	US-2003/0052323 A1	03-2003	Takeuchi et al.	257/81
*	I	US-2003/0173573 A1	09-2003	Udagawa, Takashi	257/88
*	J	US-2003/0218180 A1	11-2003	Fujiwara, Shinsuke	257/100
*	K	US-2003/0234400 A1	12-2003	Udagawa, Takashi	257/80
*	L	US-6,677,615 B2	01-2004	Takeuchi et al.	257/81
*	M	US-2004/0026703 A1	02-2004	Adomi et al.	257/81

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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